

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10567474	MICHL, ANDREAS
	Examiner	Art Unit
	JAE Y LEE	2419

SEARCHED

Class	Subclass	Date	Examiner
370	241,252,474	9/11/2008	Jae Y Lee

SEARCH NOTES

Search Notes	Date	Examiner
service access point, SAP, OSI, analyze, monitor, sniffer, mobile	9/11/2008	Jae Y Lee
Limited search using class/subclass 370/241,252,474	9/11/2008	Jae Y Lee
Inventor search: Andreas Michl	9/11/2008	Jae Y Lee
NPL search using the terms: service access point, SAP, OSI, analyze, monitor, sniffer, mobileby Google	9/11/2008	Jae Y Lee
Consulted with primary examiner Steven H. Nguyen	9/11/2008	Jae Y Lee

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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